

製品情報

Contour measuring station MarSurf CD 140 AF

製品の特徴

MarSurf CD 140 AF - Space-optimized measuring station for production

With the new MarSurf CD 140 AF, Mahr has launched a new contour measuring device onto the market. Its probe system has a measuring range of up to 70 mm, with which the probe tips can be changed quickly and without tools – and all without recalibration.

MarSurf CD 140 AF makes fast and precise measurements possible. Thanks to its flexible workpiece holder, it is particularly easy to handle and impresses with its great versatility.



品目番号 6269054

技術データ

分解能	20 nm
測定力 [N]	4 mN to 30 mN, software adjustable
測定速度	0.1 mm/s 終点 10 mm/s
Positioning speed X-axis min.	0.1 mm/s
positioning speed X-axis max.	200 mm/s
位置決め速度 (mm/s)、X軸	0.1 - 200 mm/s
プローブ	Contour tracing system
重量 (総重量)	38 KG
Workpiece weight max.	1.5 kg
その他	machine weight: 35 kg
測定範囲	70 mm with probe arm length 350 mm

付属品

注文番号	指定	製品名
6710401	V-ブロック	PP